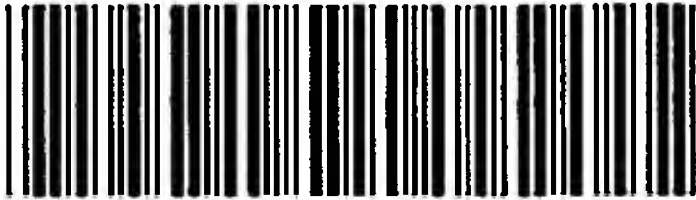


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,202	BAXTER, JOHN F.	
	Examiner	Art Unit	
	Zhiyu Lu	2682	

SEARCHED			
Class	Subclass	Date	Examiner
455		7/21/2005	ZL
455	3.01,3.02	7/22/2005	ZL
455	426	7/22/2005	ZL
455	427	7/25/2005	ZL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventorship search	7/21/2005	ZL
Consulted with Lee Nguyen	7/21/2005	ZL
Consulted with Rafael Perez	7/25/2005	ZL